



maspower

MSG25T120FL

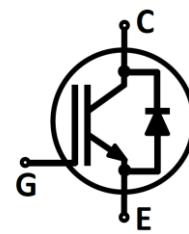
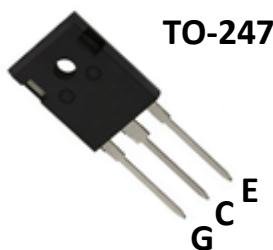
High speed Trench Fieldstop IGBT

General Description

This IGBT is produced using advanced trench fieldstop IGBT technology, which provides low $V_{CE(sat)}$, high switching performance and excellent quality.

Applications

- Welding



Absolute Maximum Ratings

Characteristics	Symbol	Rating	Unit
Collector-emitter voltage	V_{CE}	1200	V
Gate-emitter voltage	V_{GE}	± 20	V
Collector current	I_C	50	A
		25	
Pulsed collector current, t_p limited by T_{jmax}	I_{CM}	75	A
Diode forward current @ $T_C=100^\circ\text{C}$	I_F	15	A
Diode pulsed collector current, t_p limited by T_{jmax}	I_{FM}	45	A
Short circuit withstand time $V_{GE}=15\text{V}$, $V_{CC}=600\text{V}$, $T_j=25^\circ\text{C}$ Allowed number of short circuit < 1000 Time between short circuits $\geq 1.0\text{s}$	t_{SC}	3	μs
Power dissipation	P_{tot}	298	W
		119	
Operating junction temperature	T_j	-55~150	$^\circ\text{C}$
Storage temperature	T_{stg}	-55~150	

Thermal Characteristics

Characteristics	Symbol	Rating	Unit
Thermal resistance junction-to-case for IGBT	R_{thJC}	0.42	°C/W
Thermal resistance junction-to-case for Diode	R_{thJCD}	1.2	
Thermal resistance junction-to-ambient	R_{thJA}	40	

Electrical Characteristics ($T_j = 25^\circ\text{C}$ unless otherwise specified)

Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
Static Characteristics						
Collector-emitter breakdown voltage	BV_{CES}	$V_{GE}=0\text{V}, I_c=0.5\text{mA}$	1200	-	-	V
Collector-emitter saturation voltage	$V_{CE(\text{sat})}$	$V_{GE}=15\text{V}, I_c=25\text{A}$	-	2.25	2.40	
		$T_j=25^\circ\text{C}$		2.60	-	
Gate-emitter threshold voltage	$V_{GE(\text{th})}$	$T_j=150^\circ\text{C}$	5.0	6.1	7.0	
		$I_c=1\text{mA}, V_{CE}=V_{GE}$		-	-	
Zero gate voltage collector current	I_{CES}	$V_{CE}=1200\text{V}, V_{GE}=0\text{V}$	-	-	0.1	mA
		$T_j=25^\circ\text{C}$			2	
Gate-emitter leakage current	I_{GES}	$T_j=150^\circ\text{C}$	-	-	100	nA
		$V_{CE}=0\text{V}, V_{GE}=20\text{V}$			-	
Transconductance	g_{FS}	$V_{CE}=20\text{V}, I_c=25\text{A}$	-	10.5	-	S
Dynamic Characteristics						
Input capacitance	C_{iss}	$V_{CE}=25\text{V}$ $V_{GE}=0\text{V}$ $f=1\text{MHz}$	-	3480	-	pF
Output capacitance	C_{oss}		-	99	-	
Reverse transfer capacitance	C_{rss}		-	58	-	
Gate charge	Q_G	$V_{CC}=900\text{V}, I_c=25\text{A}$ $V_{GE}=15\text{V}$	-	tbd	-	nC

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Characteristics	Symbol	Test Condition	Min	Typ	Max	Unit
Switching Characteristics						
Turn-on delay time	$t_{d(on)}$	$T_j=25^\circ\text{C}$ $V_{CC}=600\text{V}$ $I_C=25\text{A}$ $V_{GE}=15/0\text{V}$ $R_G=15\Omega$ $L_{load}=500\mu\text{H}$	-	45	-	ns
Rise time	t_r		-	50	-	
Turn-off delay time	$t_{d(off)}$		-	165	-	
Fall time	t_f		-	98	-	
Turn-on switching energy	E_{on}		-	1.33	-	mJ
Turn-off switching energy	E_{off}		-	0.82	-	
Total switching energy	E_{ts}		-	2.15	-	
Turn-on delay time	$t_{d(on)}$	$T_j=150^\circ\text{C}$ $V_{CC}=600\text{V}$ $I_C=25\text{A}$ $V_{GE}=15/0\text{V}$ $R_G=15\Omega$ $L_{load}=500\mu\text{H}$	-	35	-	ns
Rise time	t_r		-	52	-	
Turn-off delay time	$t_{d(off)}$		-	200	-	
Fall time	t_f		-	225	-	
Turn-on switching energy	E_{on}		-	1.35	-	mJ
Turn-off switching energy	E_{off}		-	1.60	-	
Total switching energy	E_{ts}		-	2.95	-	
Diode Characteristics						
Forward voltage	V_F	$I_F=15\text{A}, T_j=25^\circ\text{C}$	-	1.9	-	V
		$I_F=15\text{A}, T_j=150^\circ\text{C}$	-	1.5	-	
Reverse recovery time	t_{rr}	$T_j=25^\circ\text{C}$ $V_R=600\text{V}, I_F=15\text{A}$ $di_F/dt=500\text{A}/\mu\text{s}$	-	88	-	ns
Reverse recovery charge	Q_{rr}		-	0.86	-	μC
Reverse recovery current	I_{rrm}		-	17.5	-	A
Reverse recovery time	t_{rr}	$T_j=150^\circ\text{C}$ $V_R=600\text{V}, I_F=15\text{A}$ $di_F/dt=500\text{A}/\mu\text{s}$	-	120	-	ns
Reverse recovery charge	Q_{rr}		-	1.30	-	μC
Reverse recovery current	I_{rrm}		-	20.0	-	A

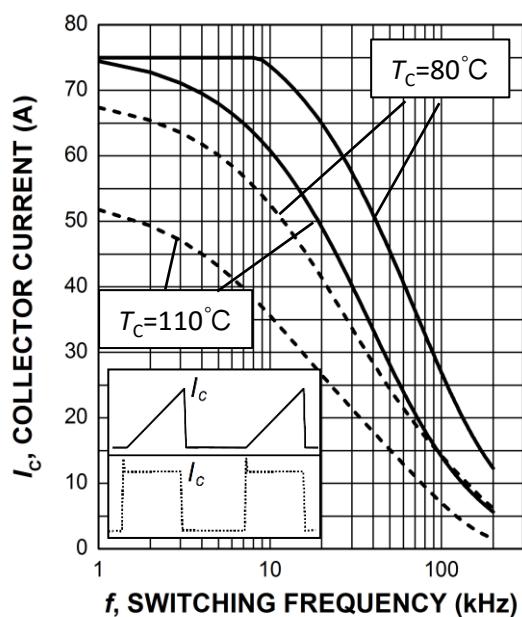


Figure 1. Collector current as a function of switching frequency
 $(T_j \leq 150^\circ\text{C}, D = 0.5, V_{CE} = 600\text{V}, V_{GE} = 0/+15\text{V}, R_G = 15\Omega)$

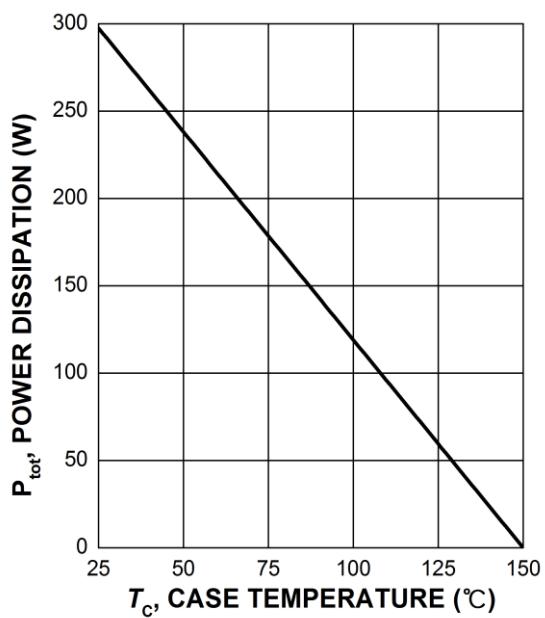


Figure 2. Maximum power dissipation as a function of case temperature
 $(T_j \leq 150^\circ\text{C})$

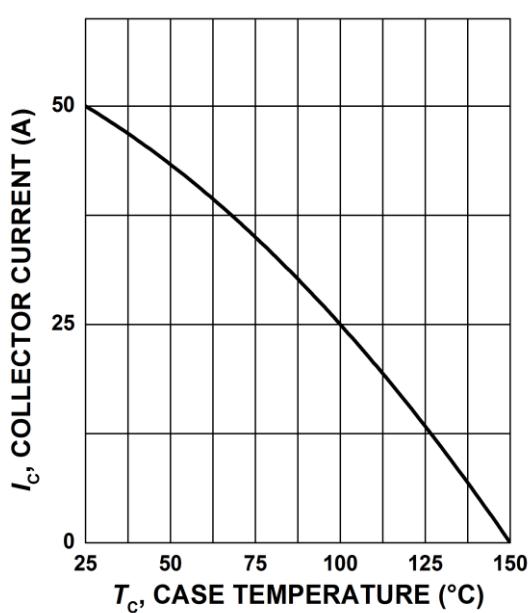


Figure 3. Maximum collector current as a function of case temperature
 $(V_{GE} \geq 15\text{V}, T_j \leq 150^\circ\text{C})$

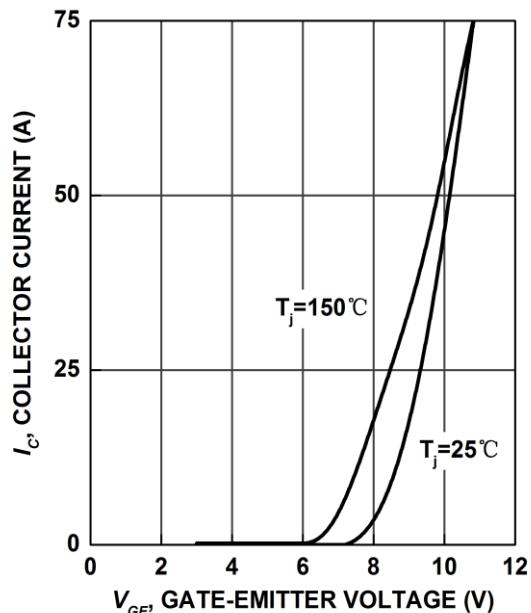


Figure 4. Typical transfer characteristic
 $(V_{CE} = 15\text{V})$

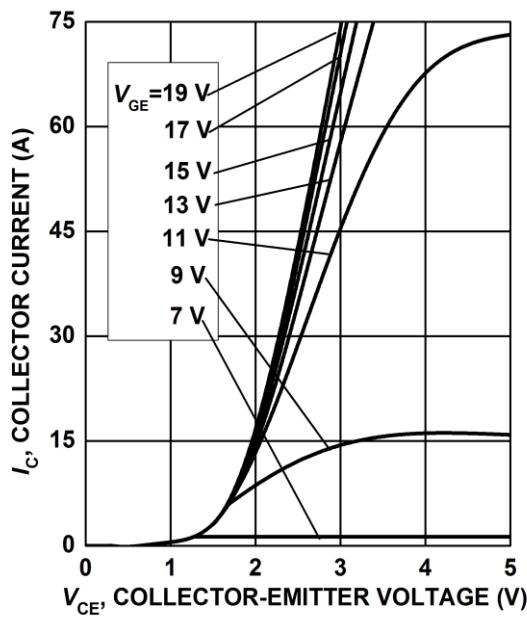


Figure 5. Typical output characteristic
($T_j = 25^\circ\text{C}$)

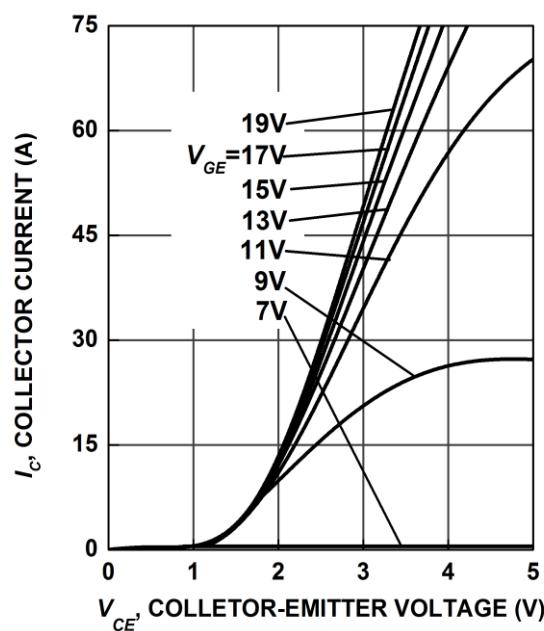


Figure 6. Typical output characteristic
($T_j = 150^\circ\text{C}$)

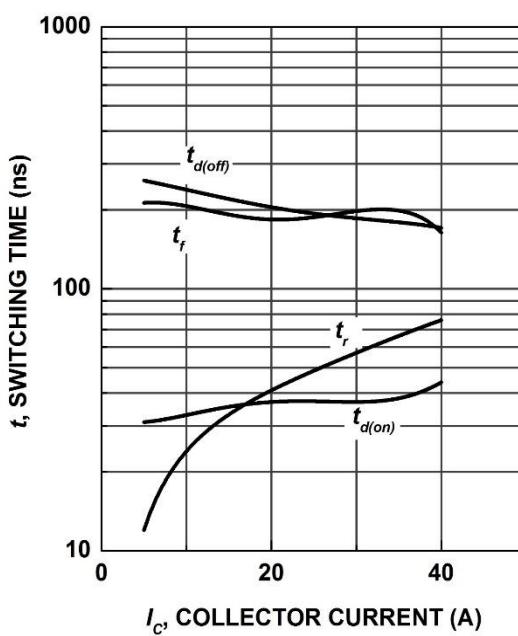


Figure 7. Typical switching times as a function of collector current
(inductive load, $T_j=150^\circ\text{C}$, $V_{CE}=600\text{V}$,
 $V_{GE}=0/15\text{V}$, $R_G=15\Omega$,
Dynamic test circuit in Figure D)

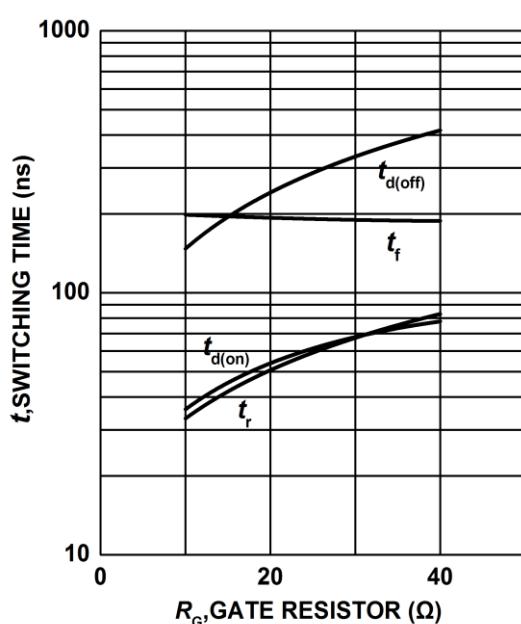


Figure 8. Typical switching times as a function of gate resistor
(inductive load, $T_j=150^\circ\text{C}$, $V_{CE}=600\text{V}$,
 $V_{GE}=0/15\text{V}$, $I_c=25\text{A}$, Dynamic test circuit in Figure D)

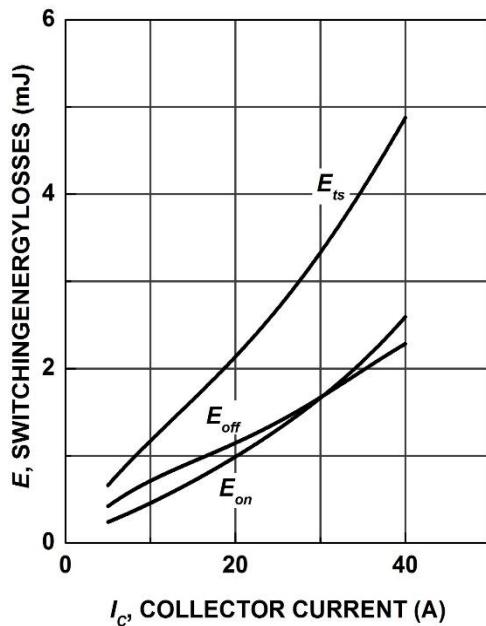


Figure 9. Typical switching energy losses as a function of collector current
(inductive load, $T_j=150^\circ\text{C}$, $V_{CE}=600\text{V}$,
 $V_{GE}=0/15\text{V}$, $R_G=15\Omega$,
Dynamic test circuit in Figure D)

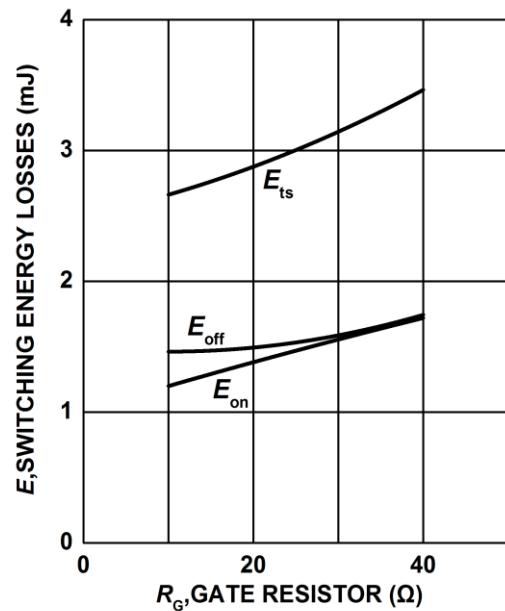


Figure 10. Typical switching energy losses as a function of gate resistor
(inductive load, $T_j=150^\circ\text{C}$, $V_{CE}=600\text{V}$,
 $V_{GE}=0/15\text{V}$, $I_C=25\text{A}$,
Dynamic test circuit in Figure D)

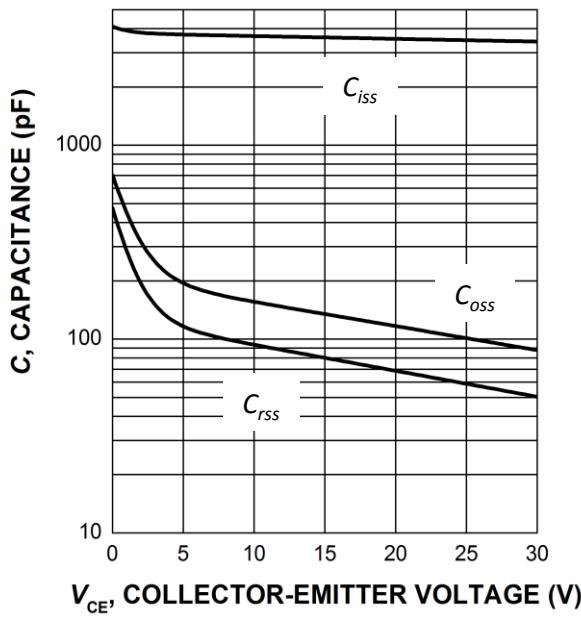


Figure 11. Typical capacitance as a function of collector-emitter voltage
($V_{GE}=0\text{V}$, $f = 1 \text{ MHz}$)

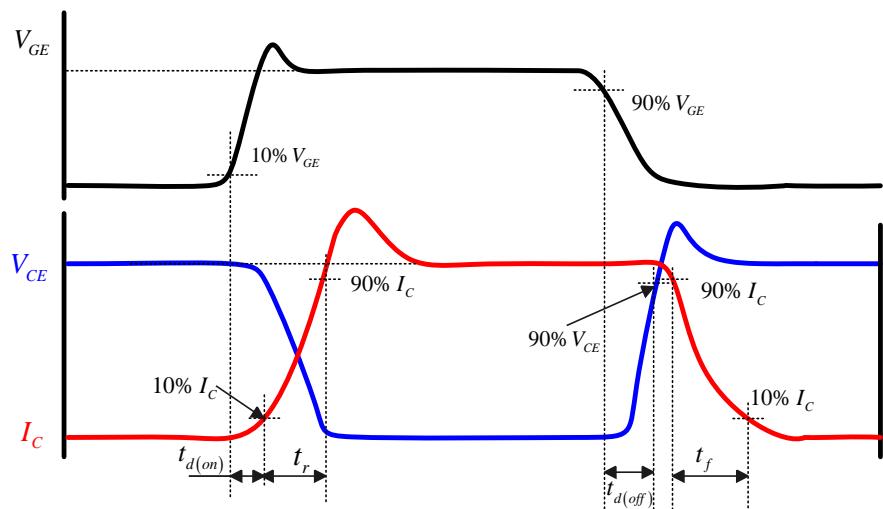


Figure A. Definition of switching times

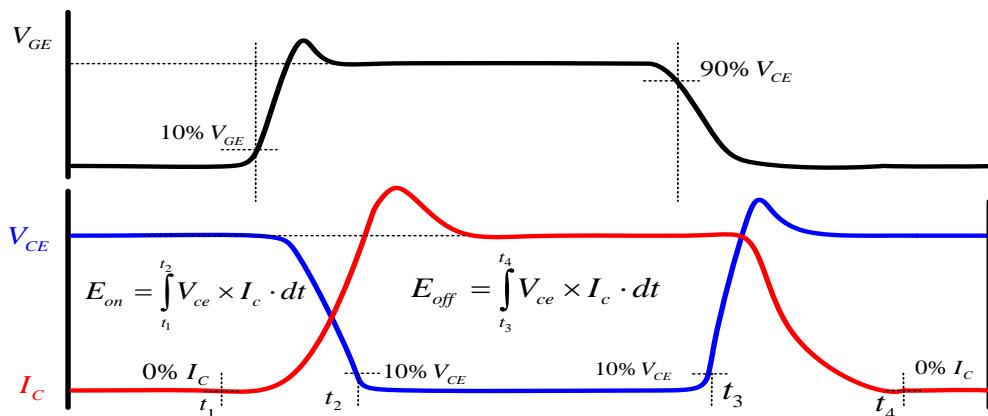


Figure B. Definition of switching losses

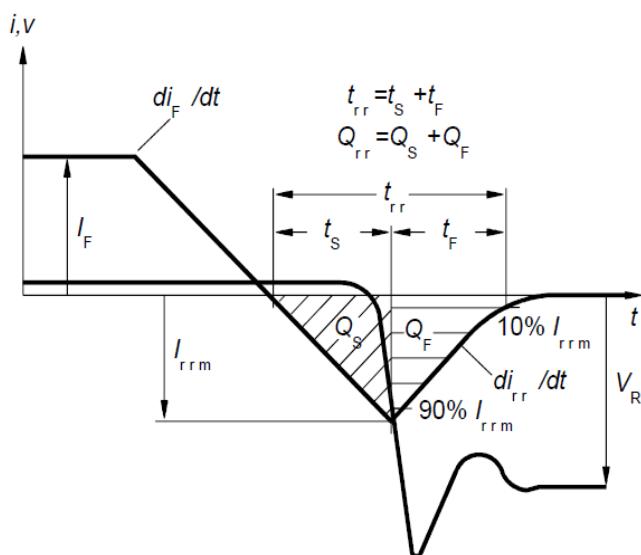


Figure C. Definition of diodes switching characteristics

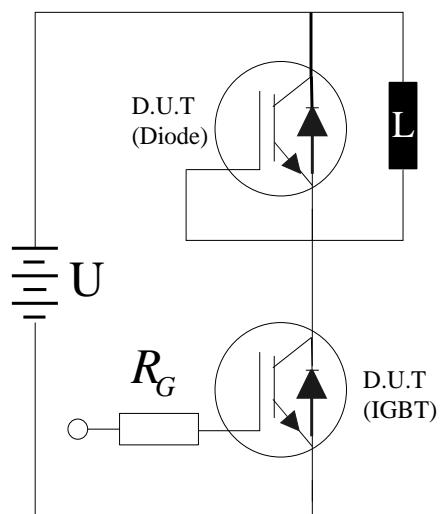


Figure D. Dynamic test circuit

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